SDLS080

SN5422, SN54LS22, SN54S22, SN74S22 SN7422, SN74LS22, SN74S22 DUAL 4-INPUT POSITIVE-NAND GATES WITH OPEN-COLLECTOR OUTPUTS DECEMBER 1983 — REVISED MARCH 1988

 Package Options Include Plastic "Small Outline" Packages, Ceramic Chip Carriers and Flat Packages, and Plastic and Ceramic Dipe

 Dependable Texas Instruments Quality and Reliability

description

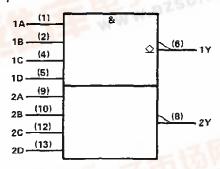
These devices contain two independent 4-input NAND gates. The open-collector outputs require pull-up resistors to perform correctly. They may be connected to other open-collector outputs to implement active-low wired-OR or active-high wired-AND functions. Open-collector devices are often used to generate higher VOH levels.

The SN5422, SN54LS22 and SN54S22 are characterized for operation over the full military temperature range of $-55\,^{\circ}\text{C}$ to $125\,^{\circ}\text{C}$. The SN7422, SN74LS22, and SN74S22 are characterized for operation from $0\,^{\circ}\text{C}$ to $70\,^{\circ}\text{C}$.

FUNCTION TABLE (each gate)

	INP	uts		OUTPUT
Α	В	С	D	Y
Н	Н	Н	н	L
L	X	X	-x	н
Х	L	Х	х	Н
Х	×	L	×	н
Х	X	X	L	н

logic symbol[†]



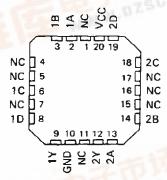
[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

Pin numbers shown are for D, J, N, and W packages.

SN5422, SN54LS22, SN54S22 . . . J OR W PACKAGE SN7422 . . . N PACKAGE SN74LS22, SN74S22 . . . D OR N PACKAGE (TOP VIEW)

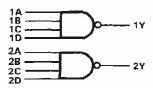
1A [1	14 ∨ _{CC}
1B [2	13 🗖 2D
NC C	3	12 2C
1C [4	11□ NC
1D 🗀	5	10 2B
1Y [6	9 🗀 2A
GND [7	8 🗍 2 Y

\$N54L\$22, \$N54\$22 ... FK PACKAGE (TOP VIEW)



NC-No internal connection

logic diagram



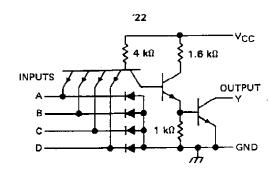
positive logic

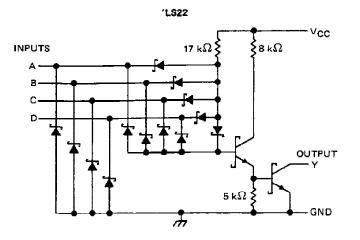
 $Y = A \cdot B \cdot C \cdot D$ or $Y \approx A + B + C + D$

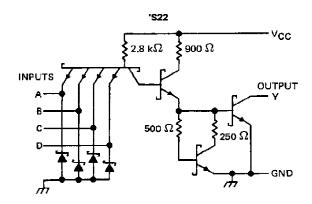
dzsc.com



schematics (each gate)







Resistor values shown are nominal.

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, VCC (See Note 1)		7 V
Input voltage: '22, '\$22		5.5 V
LS22		7 V
Operating free-air temperature range:	SN54'	-55°C to 125°C
, ,	SN74'	0° C to 70°C
Storage temperature range		-65°C to 150°C

NOTE 1: Voltage values are with respect to network ground terminal.



SN5422, SN7422 DUAL 4-INPUT POSITIVE-NAND GATES WITH OPEN-COLLECTOR OUTPUTS

recommended operating conditions

		, ;	SN5422			SN7422			
		MIN	NOM	MAX	MIN	МОМ	MAX	UNIT	
V _{CC} Supply vo	oltage	4.5	5	5.5	4.75	5	5.25	٧	
V _{IH} High-level	input voltage	2			2			٧	
V _{IL} Low-level	input voltage		•	8.0			0.8	٧	
V _{OH} High-level	output voltage			5,5			5.5	٧	
IOL Low-level	output current			16			16	mA	
TA Operating	free-air temperature	- 55		125	0		70	°C	

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

DADAMETER	TEST CONDITIONS T	SN5422	SN7422	UNIT
PARAMETER	TEST CONDITIONS.	MIN TYP [‡] MAX	MIN TYP# MAX	UNII
ViK	$V_{CC} = MIN$, $I_{I} = -12 \text{ mA}$	- 1.5	- 1.5	>
	$V_{CC} = MIN$, $V_{IL} = 0.8 \text{ V}$, $V_{QH} = 5.5 \text{ V}$		0.25	mA
Іон	$V_{CC} = MIN$, $V_{IL} = 0.7 \text{ V}$, $V_{OH} = 5.5 \text{ V}$	0.25		INA
VOL	$V_{CC} = MIN$, $V_{IH} = 2 V$, $I_{OL} = 16 mA$	0.2 0.4	0.2 0.4	V
l _l	$V_{CC} = MAX$, $V_{\parallel} = 5.5 \text{ V}$	1	1	mA
ļН	V _{CC} = MAX, V = 2.4 V	40	40	μΑ
Iμ	$V_{CC} = MAX$, $V_I = 0.4 V$	-1.6	-1.6	mA
Іссн	$V_{CC} = MAX, V_I = 0$	2 4	2 4	mA
ICCL	$V_{CC} = MAX$, $V_I = 4.5 V$	6 11	6 11	mA

^TFor conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

switching characteristics, VCC = 5 V, TA = 25°C (see note 2)

PARAMETER	FROM ((NPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN TYP	MAX	UNIT
^t PLH	Any	*	$R_L = 4 k \Omega$, $C_L = 15 pF$	35	45	កន
^t PHL	Any Y	$R_L = 400 \Omega$, $C_L = 15 pF$	8	15	ns	

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

 $^{^{\}ddagger}AII$ typical values are at VCC = 5 V, TA = 25 °C.

SN54LS22, SN74LS22 DUAL 4-INPUT POSITIVE-NAND GATES WITH OPEN-COLLECTOR OUTPUTS

recommended operating conditions

		SN54LS22			SN74LS22			
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
V _{CC} Supply voltage	4.5	5	5.5	4.75	5	5.25	V	
V _{1H} High-level input voltage	2			2			٧	
V _{1L} Low-level input voltage			0.7			0.8	V	
VOH High-level output voltage			5.5		_	5.5	٧	
OL Low-level output current			4		•	8	mΑ	
TA Operating free-air temperature	– 55		125	0	•	70	°c	

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

		TEST CONDITIONS ?		8	N54LS	22	SN74 LS22			
PARAMETER				MIN	TYP‡	MAX	MIN	TYP\$	MAX	UNIT
VIK	V _{CC} = MIN,	t _I = - 18 mA				- 1.5			- 1.5	٧
10н	V _{CC} = MIN,	VIL = MAX,	V _{OH} = 5.5 V			0.1			0.1	mA
	V _{CC} = MIN,	V _{IH} = 2 V,	IOL = 4 mA		0.25	0.4	i i	0.25	0.4	0.4 0.5
VOL	V _{CC} = MIN,	V _{IH} = 2 V,	I _{OL} = 8 mA					0.35	0.5	
I _I	V _{CC} = MAX,	V ₁ = 7 V				0.1			0.1	mΑ
IIH	V _{CC} = MAX.	V ₁ = 2.7 V				20			20	μА
l _{IL}	V _{CC} = MAX,	V1 = 0.4 V			**	- 0.4			- 0.4	mA
ГССН	V _{CC} = MAX,	v ₁ = 0			0.4	8.0		0.4	8.0	mΑ
ICCL	V _{CC} = MAX,	V _I = 4.5 V			1.2	2.2		1.2	2.2	mA

[†] For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. ‡ All typical values are at V_{CC} = 5 V, T_A = 25°C.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$ (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS		MIN TYP	MAX	UNIT
tPLH	Any	Y	$R_1 = 2 k\Omega$, $C_1 = 15 pF$		17	32	ns
ФНL	, , ,	•	,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,		15	28	ПS

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

SN54S22, SN74S22 **DUAL 4-INPUT POSITIVE-NAND GATES WITH OPEN-COLLECTOR OUTPUTS**

recommended operating conditions

		SN54S22			SN74S22			
	MIN	NOM	MAX	MIN	NOM	MAX	UNIT	
V _{CC} Supply voltage	4.5	5	5.5	4.75	5	5.25	٧	
V _{IH} High-level input voltage	2			2			٧	
VIL Low-level input voltage			0,8			8,0	٧	
VOH High-level output voltage			5. 5			5.5	٧	
IOL Low-level output current			20			20	mA	
TA Operating free-air temperature	– 55		125	0		70	°С	

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

	TEST CONDITIONS†	SN54S22	SN74S22	UNIT
PARAMETER	TEST CONDITIONS.	MIN TYP [‡] MAX	MIN TYP [‡] MAX	ONII
VIK	V _{CC} = MIN, I _I = -18 mA	-1.2	-1.2	٧
	V _{CC} = MIN, V _{IL} = 0.8 V, V _{OH} = 5.5 V		0.25	mA
10н	V _{CC} = MIN, V _{IL} = 0.7 V, V _{OH} = 5.5 V	0.25		ША
VOL	V _{CC} = MIN, V _{IH} = 2 V, I _{OL} = 20 mA	0.5	0.5	٧
Ŋ	V _{CC} = MAX, V _I = 5.5 V	1	1	mΑ
ļін	V _{CC} = MAX, V _I = 2.7 V	50	50	μΑ
l _I L	$V_{CC} = MAX$, $V_{\parallel} = 0.5 \text{ V}$	-2	- 2	mA
¹ ссн	$V_{CC} = MAX$, $V_I = 0$	3 6.6	3 6.6	mΑ
ICCL	$V_{CC} = MAX$, $V_{\parallel} = 4.5 \text{ V}$	10 18	10 18	mA

 $^{^{\}dagger}$ For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions. ‡ All typical values are at V_{CC} = 5 V, T_A = 25 °C.

switching characteristics, $V_{CC} = 5 \text{ V}$, $T_A = 25^{\circ}\text{C}$ (see note 2)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST COM	MIN	ТҮР	MAX	UNIT	
t P LH			R ₁ = 280 Ω,	6 15 - 5	2	5	7.5	ns
t _{PHL}	Any		H[= 200 12,	C _L - 15 pF	2	4.5	7	ns
[†] PLH	en. A	· ·	R _L → 280 Ω,	C _{L,} = 50 pF		7.5		ns
[†] PH Ł						7		ns

NOTE 2: Load circuits and voltage waveforms are shown in Section 1.

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